



**INDUSTRY STANDARD OF THE
PEOPLE'S REPUBLIC OF CHINA**

SJ/T 12013-2025

**Electroluminescence Imaging Test Method for Crystalline
Silicon Photovoltaic Modules
(English Translation)**

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Table of Contents

What this standard covers	1
Document data	2

What this standard covers

This standard specifies requirements??including test equipment, test environment, test preparation, test procedures, and test reporting??for electroluminescence (EL) imaging testing of crystalline silicon photovoltaic modules. It applies to indoor EL imaging testing of crystalline silicon photovoltaic modules; outdoor testing may also refer to this standard.

Document data

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